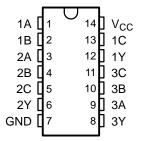


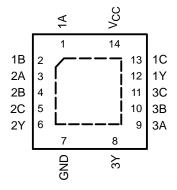
### **FEATURES**

- Operates From 1.65 V to 3.6 V
- Specified From -40°C to 85°C and - 40°C to 125°C
- Inputs Accept Voltages to 5.5 V
- Max t<sub>pd</sub> of 4.9 ns at 3.3 V
- Typical V<sub>OLP</sub> (Output Ground Bounce)
   <0.8 V at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25°C
- Typical V<sub>OHV</sub> (Output V<sub>OH</sub> Undershoot)
   >2 V at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25°C
- Latch-Up Performance Exceeds 250 mA Per JESD 17
- ESD Protection Exceeds JESD 22
  - 2000-V Human-Body Model (A114-A)
  - 200-V Machine Model (A115-A)

# D, DB, NS, OR PW PACKAGE (TOP VIEW)



### RGY PACKAGE (TOP VIEW)



### **DESCRIPTION/ORDERING INFORMATION**

This triple 3-input positive-NAND gate is designed for 1.65-V to 3.6-V V<sub>CC</sub> operation.

The SN74LVC10A performs the Boolean function  $Y = \overline{A \cdot B \cdot C}$  or  $Y = \overline{A} + \overline{B} + \overline{C}$  in positive logic.

Inputs can be driven from either 3.3-V or 5-V devices. This feature allows the use of these devices as translators in a mixed 3.3-V/5-V system environment.

#### ORDERING INFORMATION

T <sub>A</sub>	Р	ACKAGE <sup>(1)</sup>	ORDERABLE PART NUMBER	TOP-SIDE MARKING
-40°C to 85°C	QFN - RGY	Reel of 1000	SN74LVC10ARGYR	LC10A
		Tube of 50	SN74LVC10AD	
	SOIC - D	Reel of 2500	SN74LVC10ADR	LVC10A
		Reel of 250	SN74LVC10ADT	
-40°C to 125°C	SOP - NS	Reel of 2000	SN74LVC10ANSR	LVC10A
-40°C to 125°C	SSOP - DB	Reel of 2000	SN74LVC10ADBR	LC10A
		Tube of 90	SN74LVC10APW	
	TSSOP - PW	Reel of 2000	SN74LVC10APWR	LC10A
		Reel of 250	SN74LVC10APWT	

(1) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



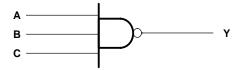
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### **FUNCTION TABLE** (EACH GATE)

	INPUTS	OUTPUT	
Α	В	С	Υ
Н	Н	Н	L
L	Χ	Χ	Н
Χ	L	Χ	Н
Χ	X	L	Н

## LOGIC DIAGRAM, EACH GATE (POSITIVE LOGIC)



# **Absolute Maximum Ratings** (1)

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage range		-0.5	6.5	V
VI	Input voltage range <sup>(2)</sup>	Input voltage range (2)		6.5	V
Vo	Output voltage range <sup>(2)(3)</sup>		-0.5	V <sub>CC</sub> + 0.5	V
I <sub>IK</sub>	Input clamp current	V <sub>I</sub> < 0		-50	mA
I <sub>OK</sub>	Output clamp current	V <sub>O</sub> < 0		-50	mA
lo	Continuous output current			±50	mA
	Continuous current through V <sub>CC</sub> or GND			±100	mA
		D package <sup>(4)</sup>		86	
		DB package <sup>(4)</sup>		96	
$\theta_{JA}$	Package thermal impedance	NS package (4)		76	°C/W
		PW package <sup>(4)</sup>		113	
		RGY package <sup>(5)</sup>		47	
T <sub>stg</sub>	Storage temperature range		-65	150	°C
P <sub>tot</sub>	Power dissipation	$T_A = -40^{\circ}C \text{ to } 125^{\circ}C^{(6)(7)}$		500	mW

Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

The value of  $V_{CC}$  is provided in the recommended operating conditions table.

The package thermal impedance is calculated in accordance with JESD 51-7.

The package thermal impedance is calculated in accordance with JESD 51-5. For the D package: above 70°C, the value of P<sub>tot</sub> derates linearly with 8 mW/K. For the DB, NS, and PW packages: above 60°C, the value of P<sub>tot</sub> derates linearly with 5.5 mW/K.



# Recommended Operating Conditions<sup>(1)</sup>

			T <sub>A</sub> =	25°C	-40 TO	O 85°C	-40 TO	125°C	UNIT	
			MIN	MAX	MIN	MAX	MIN	MAX	UNII	
	Complexedtana	Operating	1.65	3.6	1.65	3.6	1.65	3.6	V	
$V_{CC}$	Supply voltage	Data retention only	1.5		1.5		1.5		V	
		V <sub>CC</sub> = 1.65 V to 1.95 V	$0.65 \times V_{CC}$		$0.65 \times V_{CC}$		$0.65 \times V_{CC}$			
$V_{IH}$	High-level input voltage	V <sub>CC</sub> = 2.3 V to 2.7 V	1.7		1.7		1.7		V	
	voltage	V <sub>CC</sub> = 2.7 V to 3.6 V	2		2		2			
		V <sub>CC</sub> = 1.65 V to 1.95 V		$0.35 \times V_{CC}$		$0.35 \times V_{CC}$		$0.35 \times V_{CC}$		
$V_{IL}$	Low-level input voltage	V <sub>CC</sub> = 2.3 V to 2.7 V		0.7		0.7		0.7	V	
		V <sub>CC</sub> = 2.7 V to 3.6 V		0.8		0.8		0.8		
VI	Input voltage		0	5.5	0	5.5	0	5.5	V	
Vo	Output voltage		0	V <sub>CC</sub>	0	V <sub>CC</sub>	0	V <sub>CC</sub>	V	
		V <sub>CC</sub> = 1.65 V		-4		-4		-4		
	High-level	V <sub>CC</sub> = 2.3 V		-8		-8		-8	A	
I <sub>OH</sub>	output current	V <sub>CC</sub> = 2.7 V		-12		-12		-12	mA	
		V <sub>CC</sub> = 3 V		-24		-24		-24		
I <sub>OL</sub>		V <sub>CC</sub> = 1.65 V		4		4		4		
	Low-level output	V <sub>CC</sub> = 2.3 V		8		8		8	mA	
	current	V <sub>CC</sub> = 2.7 V		12		12		12		
		V <sub>CC</sub> = 3 V		24		24		24		

<sup>(1)</sup> All unused inputs of the device must be held at  $V_{CC}$  or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

## **Electrical Characteristics**

over recommended operating free-air temperature range (unless otherwise noted)

PAR-	TEST CONDITIONS	V	T <sub>A</sub> =	T <sub>A</sub> = 25°C			–40 TO 85°C		-40 TO 125°C	
AMETER	TEST CONDITIONS	V <sub>cc</sub>	MIN	TYP M	X	MIN	MAX	MIN	MAX	UNIT
	I <sub>OH</sub> = -100 μA	1.65 V to 3.6 V	V <sub>CC</sub> - 0.2		V <sub>C</sub>	<sub>0</sub> – 0.2		V <sub>CC</sub> - 0.3		
	$I_{OH} = -4 \text{ mA}$	1.65 V	1.29			1.2		1.05		
V	$I_{OH} = -8 \text{ mA}$	2.3 V	1.9			1.7		1.55		V
V <sub>OH</sub>	I <sub>OH</sub> = -12 mA	2.7 V	2.2			2.2		2.05		V
		3 V	2.4			2.4		2.25		
	I <sub>OH</sub> = -24 mA	3 V	2.3			2.2		2		
	I <sub>OL</sub> = 100 μA	1.65 V to 3.6 V		(	.1		0.2		0.3	
	$I_{OL} = 4 \text{ mA}$	1.65 V		0.	24		0.45		0.6	
V <sub>OL</sub>	$I_{OL} = 8 \text{ mA}$	2.3 V		(	.3		0.7		0.75	V
	I <sub>OL</sub> = 12 mA	2.7 V		(	.4		0.4		0.6	
	I <sub>OL</sub> = 24 mA	3 V		0.	55		0.55		0.8	
I	V <sub>I</sub> = 5.5 V or GND	3.6 V			±1		±5		±20	μΑ
Icc	$V_I = V_{CC}$ or GND, $I_O = 0$	3.6 V			1		10		40	μΑ
Δl <sub>CC</sub>	One input at V <sub>CC</sub> – 0.6 V, Other inputs at V <sub>CC</sub> or GND	2.7 V to 3.6 V		5	00		500		5000	μΑ
C <sub>i</sub>	$V_I = V_{CC}$ or GND	3.3 V		5						pF

# SN74LVC10A TRIPLE 3-INPUT POSITIVE-NAND GATE

SCAS284N-JANUARY 1993-REVISED FEBRUARY 2005



## **SWITCHING CHARACTERISTICS**

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	$T_A = 25^{\circ}C$			5°C		-40 TO 125°C		UNIT	
(INPUT)		(OUTPUT)	V <sub>cc</sub>	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
		V	1.8 V ± 0.15 V	1	4.2	10.1	1	10.6	1	12.1	
	A P or C		2.5 V ± 0.2 V	1	2.9	7.3	1	7.8	1	9.9	20
t <sub>pd</sub>	A, B, or C	Ť	2.7 V	1	3.1	5.6	1	5.8	1	7.4	ns
			3.3 V ± 0.3 V	1	2.7	4.7	1	4.9	1	6	
t <sub>sk(o)</sub>			3.3 V ± 0.3 V					1		1.5	ns

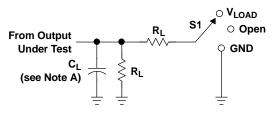
# **Operating Characteristics**

 $T_A = 25^{\circ}C$ 

	PARAMETER	TEST CONDITIONS	V <sub>cc</sub>	TYP	UNIT
			1.8 V	9	
$C_{pd}$	Power dissipation capacitance per gate	f = 10 MHz	2.5 V	10	рF
			3.3 V	11	



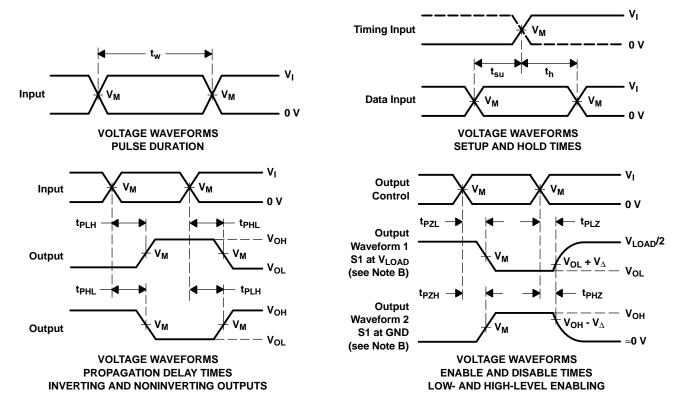
### PARAMETER MEASUREMENT INFORMATION



TEST	S1
t <sub>PLH</sub> /t <sub>PHL</sub>	Open
t <sub>PLZ</sub> /t <sub>PZL</sub>	V <sub>LOAD</sub>
t <sub>PHZ</sub> /t <sub>PZH</sub>	GND

**LOAD CIRCUIT** 

.,	INPUTS		.,	.,		_	.,
V <sub>CC</sub>	V <sub>I</sub>	t <sub>r</sub> /t <sub>f</sub>	V <sub>M</sub>	V <sub>LOAD</sub>	CL	R <sub>L</sub>	$oldsymbol{V}_{\Delta}$
1.8 V $\pm$ 0.15 V	v <sub>cc</sub>	≤2 ns	V <sub>CC</sub> /2	2×V <sub>CC</sub>	30 pF	<b>1 k</b> Ω	0.15 V
2.5 V $\pm$ 0.2 V	V <sub>CC</sub>	≤ <b>2</b> ns	V <sub>CC</sub> /2	2×V <sub>CC</sub>	30 pF	500 Ω	0.15 V
2.7 V	2.7 V	≤2.5 ns	1.5 V	6 V	50 pF	500 Ω	0.3 V
3.3 V $\pm$ 0.3 V	2.7 V	≤2.5 ns	1.5 V	6 V	50 pF	500 Ω	0.3 V



NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_0 = 50 \ \Omega$ .
- D. The outputs are measured one at a time, with one transition per measurement.
- E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
- F. t<sub>PZL</sub> and t<sub>PZH</sub> are the same as t<sub>en</sub>.
- G.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .
- H. All parameters and waveforms are not applicable to all devices.

Figure 1. Load Circuit and Voltage Waveforms





8-Mar-2005

### **PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
SN74LVC10AD	ACTIVE	SOIC	D	14	50	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAR/ Level-1-235C-UNLIM
SN74LVC10ADBLE	OBSOLETE	SSOP	DB	14		None	Call TI	Call TI
SN74LVC10ADBR	ACTIVE	SSOP	DB	14	2000	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAR/ Level-1-235C-UNLIM
SN74LVC10ADR	ACTIVE	SOIC	D	14	2500	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAR/ Level-1-235C-UNLIM
SN74LVC10ADT	ACTIVE	SOIC	D	14	250	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAR/ Level-1-235C-UNLIM
SN74LVC10ANSR	ACTIVE	SO	NS	14	2000	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAR/ Level-1-235C-UNLIM
SN74LVC10APW	ACTIVE	TSSOP	PW	14	90	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM
SN74LVC10APWLE	OBSOLETE	TSSOP	PW	14		None	Call TI	Call TI
SN74LVC10APWR	ACTIVE	TSSOP	PW	14	2000	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM
SN74LVC10APWT	ACTIVE	TSSOP	PW	14	250	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM
SN74LVC10ARGYR	ACTIVE	QFN	RGY	14	1000	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAR

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - May not be currently available - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

None: Not vet available Lead (Pb-Free).

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Green (RoHS & no Sb/Br): TI defines "Green" to mean "Pb-Free" and in addition, uses package materials that do not contain halogens,

including bromine (Br) or antimony (Sb) above 0.1% of total product weight.

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDECindustry standard classifications, and peak solder temperature.

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# D (R-PDSO-G14)

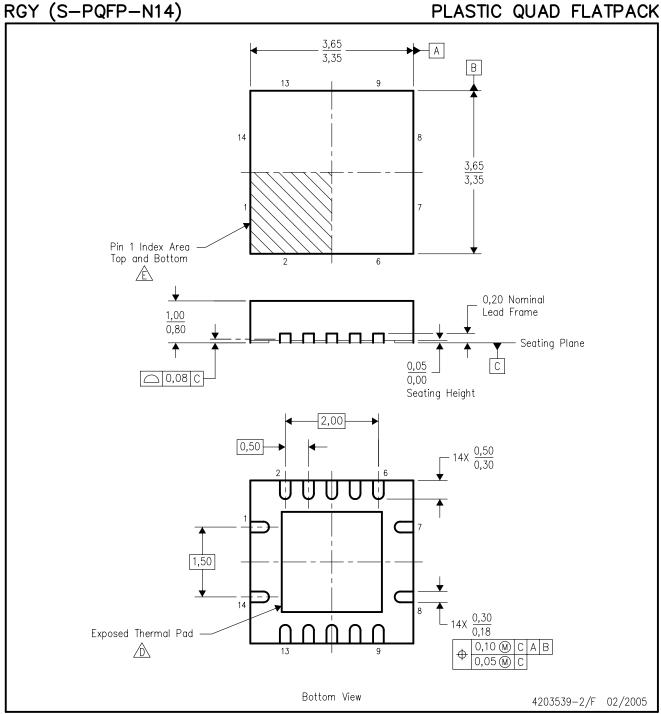
# PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-012 variation AB.





NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. QFN (Quad Flatpack No-Lead) package configuration.
- The package thermal pad must be soldered to the board for thermal and mechanical performance. See the Product Data Sheet for details regarding the exposed thermal pad dimensions.
- Pin 1 identifiers are located on both top and bottom of the package and within the zone indicated. The Pin 1 identifiers are either a molded, marked, or metal feature.
- F. Package complies to JEDEC MO-241 variation BA.



## **MECHANICAL DATA**

# NS (R-PDSO-G\*\*)

# 14-PINS SHOWN

### PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



## DB (R-PDSO-G\*\*)

## PLASTIC SMALL-OUTLINE

### **28 PINS SHOWN**



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-150

## PW (R-PDSO-G\*\*)

### 14 PINS SHOWN

## PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

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